

**Notice of References Cited**

Application/Control No.

10/537,977

Applicant(s)/Patent Under  
Reexamination  
BENARD ET AL.

Examiner

TAIWO T. OLADAPO

Art Unit

4151

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*	A	US-5,425,933	06-1995	Nakagawa, Yumi	423/706
*	B	US-6,103,674	08-2000	Nalesnik et al.	508/334
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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